

Soft x-ray spectroscopies in liquids and at solid-liquid interface at BACH beamline at Elettra

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ABSTRACT

The beamline for advanced dichroism of the Istituto Officina dei Materiali-Consiglio Nazionale delle Ricerche, operating at the Elettra synchrotron in Trieste (Italy), works in the extreme ultraviolet–soft x-ray photon energy range with selectable light polarization, high energy resolution, brilliance, and time resolution. The beamline offers a multi-technique approach for the investigation of the electronic, chemical, structural, magnetic, and dynamical properties of materials. Recently, one of the three end stations has been dedicated to experiments based on electron transfer processes at the solid/liquid interfaces and during photocatalytic or electrochemical reactions. Suitable cells to perform soft x-ray spectroscopy in the presence of liquids and reagent gases at ambient pressure were developed. Here, we present two types of static cells working in transmission or in fluorescence yield and an electrochemical flow cell that allows us to carry out cyclic voltammetry *in situ* and electrodeposition on a working electrode and to study chemical reactions under *operando* conditions. Examples of x-ray absorption spectroscopy measurements performed under ambient conditions and during electrochemical experiments in liquids are presented.

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I. INTRODUCTION

The global demand for energy and environmental sustainability requires the development of new methods to enable the comprehensive understanding of the electron transfer processes at the solid/liquid interfaces. Photocatalytic and electrochemical reactions such as CO₂ reduction reaction (CO₂RR), oxygen reduction reaction (ORR), oxygen evolution reaction (OER), and hydrogen

evolution reaction (HER) represent a milestone in the current concepts of sustainable energy research.^{1,2} A rational design of new catalysts and (photo)-electrocatalysts must rely on detailed understanding of the reaction mechanisms occurring at the surface of the catalysts. Spectroscopic techniques based on synchrotron radiation are pivotal to provide significant insight into the behavior of electrocatalysts under operating conditions. In particular, an exhaustive comprehension of the electronic properties of materials in ambient

pressure gas or in liquid environment is required, as well as a mechanistic understanding of the electronic evolution occurring at the solid/liquid or solid/gas interfaces during catalytic or electrochemical reactions.

In order to characterize such interfaces *in situ*, one would need a probe that can penetrate the solid and/or the liquid layer while generating collectable signals from the interface layer (typically several nanometers thick) or from the bulk region of the solution. Therefore, there is an increasing demand to develop techniques or to implement the existing ones to study phenomena at the interfaces under *in situ* or *operando* conditions.

Several *in situ* cells have been recently designed for various synchrotron-based x-ray techniques, such as x-ray diffraction (XRD),^{3,4} scanning/transmission x-ray microscopy (STXM/TXM),^{5,6} and x-ray spectroscopies (absorption and photoemission) in the hard x-ray range^{7,8} and in the soft x-ray energy range.^{9–12}

Among the x-ray spectroscopic techniques, extreme ultraviolet (EUV) and soft x-ray spectroscopies (SXS) are characterized by intrinsic surface sensitivity, which allows studying physical and chemical processes occurring at the material surfaces and interfaces. Moreover, SXS techniques enable us to investigate the L-edges of the first-row transition metals, M_{5,4} edges of the rare-earth elements, and K-edges of light elements such as Li, Be, B, C, O, N, and F. The absorption spectroscopy is element and chemical-state sensitive and provides information about the unoccupied electronic states with few to hundreds of nanometer probing depth, allowing the study of variations in the electronic structure of the materials, such as the oxidation state and ligand field strength, which change during the electrochemical and energy conversion processes involved in fuel cells or batteries.

The electronic structure can be probed by photon-in/electron-out techniques such as x-ray photoelectron spectroscopy (XPS) or x-ray absorption (XAS) in total electron yield mode (TEY) and by photon-in/photon-out techniques such as XAS in total fluorescence yield mode (TFY) and x-ray emission spectroscopy (XES).

These techniques typically require ultra-high vacuum (UHV) conditions, making their application to the study of catalytic and (photo)-electrochemical processes under operating environments difficult. For this reason, it is important to bridge the “pressure gap” between UHV and ambient pressure by integrating SXS techniques into ambient or near-ambient pressure environments.

So far, different approaches have been developed.¹³ The first is near-ambient pressure photoelectron spectroscopy (NAP-XPS)^{14–19} in which the sample is kept under conditions close to the ambient environment, and in some cases, a very thin liquid layer is condensed on top of the sample. This setup requires a differentially pumped electrostatic pre-lens system with a three-stage differentially pumped analyzer. The second approach is the use of liquid microjets/droplet trains in combination with differentially pumped photoelectron analyzers and high brilliance synchrotron radiation sources for *in situ* XAS and XPS measurements.²⁰ This system allows the solid/liquid interface characterization at the nanoparticle surface, but it is not suitable for electrochemistry experiments. The main advantages in using liquid microjets or droplet trains are the negligible beam damage and sample contamination. In addition, the use of a liquid droplet train in combination with a delay-line detector enables performing time-resolved studies, with the

possibility to explore time scales spanning from seconds down to microsecond.

The third approach is based on the confinement of a liquid or a gas in environmental cells (E-cells) with windows separating the fluid from the vacuum, which exploit the ability of photons to travel deeper in solid materials (up to thousands of Å). The window material has to be chosen appropriately as it should be inert toward the cell components, such as electrodes and electrolytes, and it should be resistant to the oxidation and reduction during charge processes, be mechanical resistant to withstand large pressure differences, and be transparent enough to the x rays. For these reasons, a thin Si₃N₄ membrane is usually used, but recently, also graphene membranes have been successfully employed to confine the liquid in the cell^{21,22} or on an appropriate substrate.^{23,24}

Several types of cells have been developed: static²⁵ or microfluidic,²⁶ working at high liquid pressure¹¹ in transmission^{9,27} or in reflection geometry.²⁸

Following the last approach, two types of cells dedicated to soft x-ray absorption spectroscopy measurements have been developed to fit the Beamline for Advanced diCHroism (BACH) beamline parameters: (1) static cells working in transmission and in fluorescence yield and (2) microfluidic cells dedicated to *operando* electrochemical experiments. The cells were developed and fabricated in house by the technical group of the Istituto Officina dei Materiali-Consiglio Nazionale delle Ricerche (IOM-CNR). In the present work, we report a detailed description of the developed cells together with some proof-of-concept measurements performed at the O K-edge in various liquid solutions and transition metal (TM) L-edge spectra obtained during electrochemical experiments in the microfluidic cell.

II. THE *IN SITU*/OPERANDO CELLS

A. Static liquid cells (transmission and fluorescence yield)

Two types of static liquid cells (presented in Fig. 1) have been developed with the aim of using two photon-in/photon-out detection modes. The first cell [(a)—cell 1] works in fluorescence yield, and it consists of a thin x-ray transparent membrane that separates the vacuum chamber from the liquid reservoir. The second type of cell [(b)—cell 2] operates in transmission mode and it consists of two thin membranes clamped together to form an inner space where the liquid is confined.

The used membranes are typically made of Si₃N₄, but different materials, such as SiO₂ or SiC, could be used to optimize the transmission for the absorption edges under investigation. The typical membrane window dimensions are 1 × 1 mm² with a thickness of 100 nm, and the silicon frame is 1 × 1 cm² wide with a thickness of 200 μm–500 μm. These parameters were chosen as a compromise between the x-ray transmission and the mechanical strength of the membrane itself.

The calculated transmission curve²⁹ considering Si₃N₄ of a total thickness of 200 nm is reported in Fig. 1(b) (bottom panel, black dashed line). The curve reproduces the signal transmitted through two 100-nm-thick windows, excluding the presence of any medium inside the cell. In the soft x-ray energy range of interest (>250 eV to

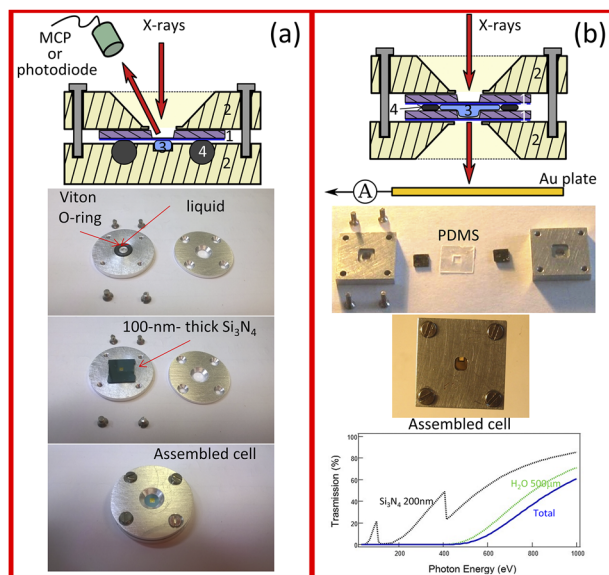


FIG. 1. (a) Static liquid cell for XAS in fluorescence yield. On top, a scheme of the cell and the used experimental geometry is reported. A 100 nm-thick-Si₃N₄ window (1) pressed between two aluminum or PEEK plates (2) closes the liquid in a small cavity (3). A Viton O-ring (4) ensures the sealing of the cell. The pictures show the components of a cell made of aluminum. (b) Static liquid cell for XAS in transmission. Top: a scheme of the cell and the used experimental geometry. Two 100 nm-thick-Si₃N₄ windows (1) pressed between two aluminum plates (2) encapsulate a small volume of the liquid of $\sim 500 \mu\text{m}$ thickness (3). The seal is guaranteed by a $100 \mu\text{m}$ -thick PDMS layer (4). The signal is collected by a picoammeter connected to an Au plate. The pictures show the components of the cell. Bottom right: the total transmission curve (blue line), calculated considering 200 nm-thick Si₃N₄ (black line) and 500 μm -thick liquid H₂O (green dotted line), is shown.

probe also C K-edge at $\sim 285 \text{ eV}$ – 290 eV), the transmission is higher than 20%, which permits us to achieve a good signal-to-noise ratio in the acquired spectra in a reasonable time.

The Si₃N₄ membranes were fabricated at the nanofabrication IOM-CNR facility following standard procedures of photolithography.³⁰

In detail, for cell 1 [Fig. 1(a)], the Si₃N₄ membrane (1) separates the liquid volume of around $3 \mu\text{l}$ – $5 \mu\text{l}$ (3) from the UHV experimental chamber. The Viton O-ring (4) guarantees the appropriate seal to work under the UHV condition (base pressure $< 1 \times 10^{-8}$ mbar). The body of the cell is made of aluminum or polyether-ether ketone (PEEK), an UHV compatible chemically inert polymeric material, with good mechanical properties and electrical insulation. The cell is mounted on the standard sample carrier (VG XL25VH or XL25HC) available on the end station “A” of the BACH beamline inserted in a load lock and then transferred to the measurement chamber.

The cell in the load lock is pumped down to a pressure $< 1 \times 10^{-6}$ mbar first by a roughing pump at a pumping rate around 50 mbar/min from atmospheric pressure down to ~ 1 mbar and then to high vacuum with a turbo pump. Afterward, it is transferred to the measurement chamber (base pressure 10^{-9} mbar– 10^{-10} mbar).

The load lock allows us to reach the operating conditions in a relatively short time (usually 1 h), and it ensures that the pressure in the experimental chamber during the measurement is lower than 5×10^{-8} mbar. In a similar way, the cell can be taken off easily by paying attention to the N₂ venting operation, which must be done slowly from ~ 1 mbar to atmospheric pressure (rate ~ 50 mbar/min).

In Fig. 2, we report O K-edge total fluorescence yield XAS spectra obtained from various samples under environmental conditions enclosed in the static cell. The measurements were performed using radiation linearly polarized in the horizontal plane, an angle of incidence of the x rays normal to the cell window, and the spectra were acquired in fluorescence yield by an MCP (Hamamatsu F4655-13) detector at an angle of 22.5° from the normal to the membrane. The size of the beam was $300 \mu\text{m}$ (horizontally) $\times 100 \mu\text{m}$ (vertically). Figure 2 shows the O K-edge spectra from Fe₃O₄ nanoparticles (NPs) dispersed in water (black line) and TiO₂ NPs in an aqueous solution of HNO₃ (blue line), liquid H₂O (red line), and air (green line). As a reference for the background, the O K-edge signal from the Si₃N₄ window is also reported (cyan line). The spectra of Fe₃O₄ NPs, TiO₂ NPs, and H₂O show the characteristic pre-edge of liquid water at 535 eV photon energy associated with broken or weakened H-bonds, the main edge around 537 eV assigned to the unsaturated hydrogen bonds, and a post edge around 537 eV–545 eV associated with the saturated hydrogen bonding network in the bulk regions of the liquids.^{28,31} Additional features at 530 eV can be ascribed to

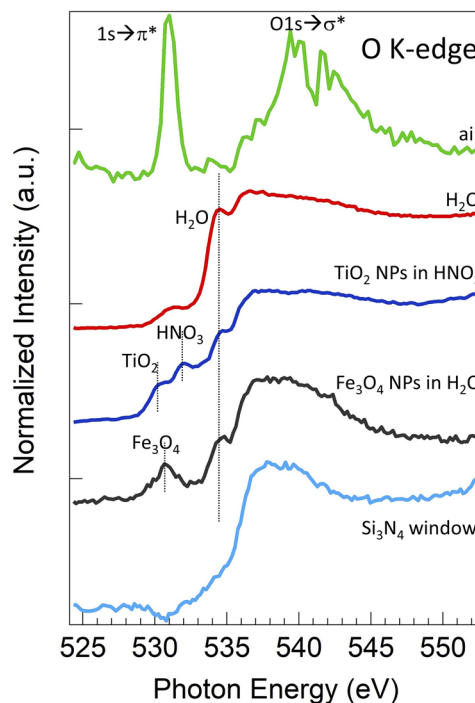


FIG. 2. O K-edge XAS of Fe₃O₄ NPs in H₂O (black line), TiO₂ NPs in HNO₃ (blue line), H₂O liquid (red line), and air (green line) encased in the static cell measured through a 100 nm-thick Si₃N₄ window in total fluorescence yield. The O K-edge signal from the Si₃N₄ window (cyan line) is reported as a reference.

3d-metal orbitals hybridized with O-2p orbitals in the crystal lattice of the NPs (TiO_2 and Fe_3O_4) or to unwanted contamination of the Si_3N_4 window in the H_2O spectrum. The peak at 532 eV of TiO_2 NPs in HNO_3 solution corresponds to interfacial NO_3 -species.³² For comparison, the O K-edge XAS spectrum obtained from the air closed in the static cell is shown (top spectrum). It is characterized by a strong resonance at 531.2 eV ($\text{O}1s \rightarrow \pi^*$ transition) and a broad absorption band in the energy range 537 eV–545 eV ($\text{O}1s \rightarrow \sigma^*$ transition) typical of O_2 gas.³³

For cell 2 [see Fig. 1(b)], two Si_3N_4 membranes (1) are sealed together by a thin layer of polydimethylsiloxane (PDMS) (4) and the enclosed liquid volume is around $0.5 \mu\text{l}$ (3), with about $500\text{-}\mu\text{m}$ -thick liquid region. The cell (mounted on a three degrees of freedom manipulator) is operated in the measurement chamber of the central branch of the beamline BACH. The XAS measurements are performed in transmission geometry by collecting the drain current on a gold foil placed on the back of the cell at a distance of few cm. The gold foil is connected to a picoammeter, as sketched in Fig. 1(b) (top panel), via a BNC feedthrough. The pumping/venting operations used to load cell 2 are similar to those described for cell 1. In this case, the turbo pump allows us to reach a vacuum $< 1 \times 10^{-7}$ mbar in 5 h–6 h. A liquid N_2 trap is also used to lower the pressure in the chamber and to reach the operating pressure $< 5 \times 10^{-8}$ mbar.

The calculated transmission curve²⁹ for this cell is reported in Fig. 1(b) (bottom panel, blue solid line), considering the transmission of the two Si_3N_4 windows of 100 nm thickness each and the transmission through a $500\text{-}\mu\text{m}$ -thick H_2O layer. The cell was tested encapsulating an aqueous solution of FeCl_3 40 mM and the transmission signal, measured in the 450 eV–750 eV photon energy

range, is reported in Fig. S1 (red circle points), showing a good agreement between the experimental data and the calculated total transmission signal.

B. Microfluidic electrochemical cell

One of the main limitations of the static cells is the possible degradation of the liquid and the formation of radicals during x-ray irradiation. Furthermore, the electrolyte can be changed only by taking off the cell and breaking the vacuum of the chamber. A new cell equipped with microfluidic channels, which can provide fresh solution and guarantee mixing and good diffusion of the liquid, was developed to overcome the problems mentioned above. Moreover, three electrical contacts were added in order to perform *operando* XAS measurements during electrochemical experiments. A schematic drawing of the cell is shown in Fig. 3. More technical details of the cell are reported in Fig. S2.

Similar to the static cell, a thin Si_3N_4 membrane separates the liquid in the cell (made in PEEK) from the vacuum of the experimental chamber. The liquid is supplied through two PEEK tubes with an inner diameter of $250 \mu\text{m}$: one for the inlet and the other one for the outlet. Both tubes are supplied with 24 V whisper microvalves (Bürkert) interlocked with the chamber pressure gauge. In the case of a pressure increase above 1×10^{-6} mbar in the experimental chamber (for example, in the case of accidental windows breaking), the valves close the liquid flow, thus limiting the liquid volume leaking into the vacuum chamber to only $19 \mu\text{l}$, i.e., the total volume of the cell (which includes the tubes between the cell body and the microvalves).

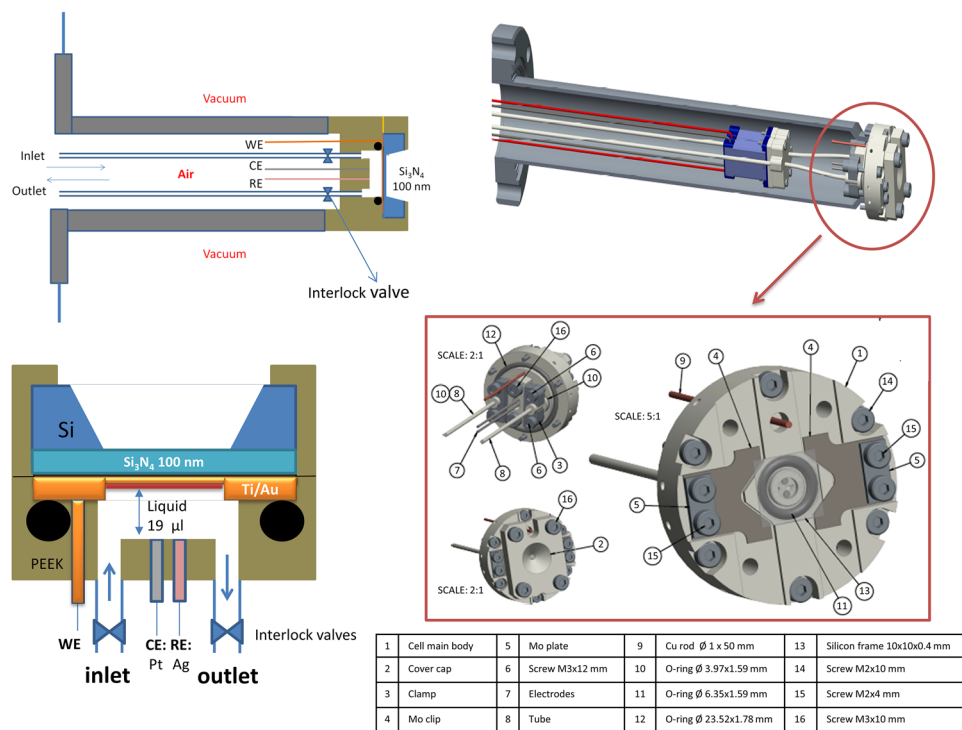


FIG. 3. Schematic drawings of the microfluidic cell for *in operando* XAS measurements. The cell is equipped with a three electrode system where the Si_3N_4 membrane is the working electrode, a 1 mm-diameter Pt wire is the counter electrode, and a 1 mm-diameter Ag wire is the quasi-reference electrode. The body of the cell in PEEK is sealed by a Viton O-ring on a tube inserted into the UHV chamber. The interlock valves are mounted on the microfluidic channels and allow us to limit the volume of the liquid in the cell during measurements.

The liquid is inserted in the tube through a syringe of 1 ml volume moved by a pump (NE-1000 Programmable Single Syringe Pump), which allows a controlled liquid flow rate in the range between $2 \times 10^{-4} \mu\text{l/s}$ and $590 \mu\text{l/s}$. A typical flow rate used in our experiments was $0.83 \mu\text{l/s}$, which corresponds to a complete replacement of the liquid in 155 s. The flow prevents the liquid samples from the radiation damage during measurements and allows us to perform experiments that require the use of different solutions without breaking the vacuum conditions.

The electrical contacts are used to carry out electrochemical experiments such as cyclic or linear sweep voltammetry (CV or LSV), electrochemical depositions, and electrochemical impedance spectroscopy (EIS) while simultaneously acquiring the XAS spectra in *operando* fashion.

The working electrode (WE) is the Si_3N_4 membrane itself coated with a Ti/Au (3 nm/15 nm) layer (thereby assuring good electrical conductivity). The membrane is pressed by a PEEK top cap on two molybdenum plates, which are electrically connected to the air side through a Cu wire. Electrically conductive and chemical resistant molybdenum clamps have been specifically designed to ensure a homogeneous current flow on the entire $\text{Si}_3\text{N}_4/\text{Ti}/\text{Au}$ membrane. The quasi-reference electrode (Ag) and the counter electrode (Pt) are two wires of 1 mm diameter placed on the bottom of the cell in contact with the solution in the cell reservoir. The electrochemical measurements were performed using an Emstat3+ (PalmSens) potentiostat.

In order to test the performance of the new microfluidic cell under standard conditions and to find the best operating parameters,

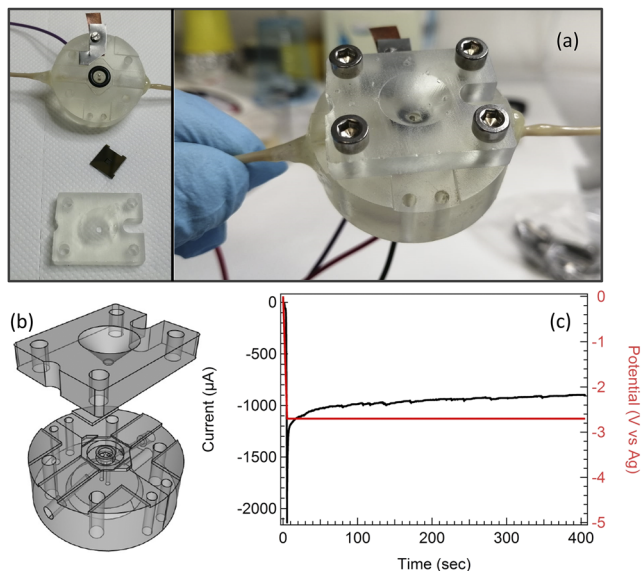


FIG. 4. (a) Pictures of the 3D printed cell used to test the cathodic electrodeposition of catalytic materials on Si_3N_4 and to carry out preliminary cyclic voltammetry measurements to optimize the operating conditions required for *operando* experiments. (b) 3D exploded drawing of the cell. (c) Plots of the current (black line) and the applied voltage (red line) vs time during Ni hydroxide $[\text{Ni}(\text{OH})_2]$ cathodic electrodeposition.

a 3D printed cell (printer: Formlabs, Form2, SilkyGenie) [Fig. 4(a)] was fabricated using a clear resin (FLGCL04) with a good chemical stability. The printing resolution was around $100 \mu\text{m}$. The cell was redesigned starting from the previous one, adapting it for the use in air. An exploded 3D drawing is reported in Fig. 4(b). For more details of the cell design, see Fig. S3. The 3D printed cell was successfully tested for several applications, such as electrodeposition of catalytic materials on the Au/Ti coated Si_3N_4 window (WE) and cyclic voltammetry measurements. As an example, the measured current and voltage during a Ni hydroxide $[\text{Ni}(\text{OH})_2]$ cathodic electrodeposition is reported in Fig. 4(c). The experiment was performed following a similar procedure, as described in the following.

III. ELECTROCHEMICAL EXPERIMENTS

A. Electrochemical deposition of $\text{Ni}(\text{OH})_2$ and cyclic voltammetry

The electrochemical microfluidic cell was successfully used for cathodic electrodeposition of $\text{Ni}(\text{OH})_2$, which can be electrochemically converted into the Ni catalytic-active phase composed by Ni oxide-hydroxide (NiOOH)³⁴ in alkaline medium, one of the most promising catalysts for OER, especially if combined with Fe-based materials, which are able to enhance its electro-catalytic activity.^{35–37} Two $\text{Ni}(\text{OH})_2$ films with different thickness were cathodically electrodeposited on the Si_3N_4 (100 nm) membrane coated with a Ti(3 nm)/Au(15 nm) conductive layer (working electrode)³⁸ from an aqueous solution containing $0.1\text{M Ni}(\text{NO}_3)_2 \times 6 \text{H}_2\text{O}$ and $25 \text{mM } (\text{NH}_4)_2\text{SO}_4$ at pH 2.5. In Fig. 5, we report the SEM images of two samples deposited by applying an average cathodic current of 0.9mA/cm^2 for 60 s [thin layer, (a) and (b)] and 2.3mA/cm^2 for 200 s [thick layer, images (c) and (d)] on a circular area of 0.31mm^2 . The thickness was estimated to be 400 nm (thin) and $4 \mu\text{m}$ (thick) assuming 0.125mC/cm^2 per 1 nm.³⁹ The

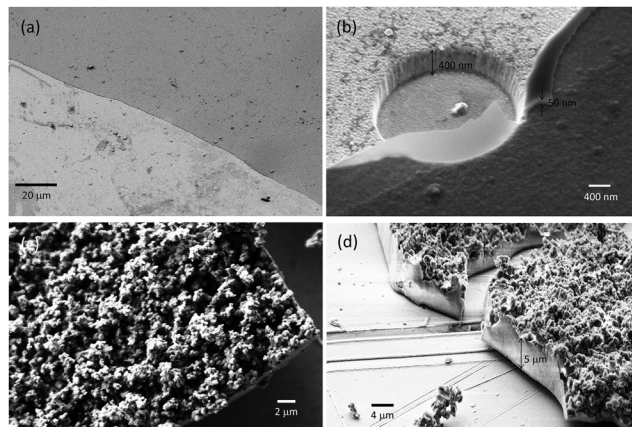


FIG. 5. SEM images of $\text{Ni}(\text{OH})_2$ layers obtained by cathodic electrodeposition and subsequent activation on a Si_3N_4 100 nm-thick membrane coated with a Ti(3 nm)/Au(15 nm) (see the text for experimental details). [(a) and (b)] SEM images of a $\sim 400 \text{nm}$ -thick film. [(c) and (d)] SEM images of a $\sim 5 \mu\text{m}$ -thick film.

images were acquired using a SEM Zeiss supra40 instrument, with a 10 nm lateral resolution and voltage set to 2 kV–5 kV. The thin film appears uniform [Fig. 5(a)], composed of a dense layer of pillars around 400 nm high, partially covered by a second thinner layer (50 nm), as evidenced by the circular defect reported in the high resolution image [Fig. 5(b)] with the aim to show clearly the morphology and the thickness of the sample. The thick layer reveals a double structure: a very dense one at the bottom and a second porous cauliflower-like structure on the top with a total thickness around 5 μm [Figs. 5(c) and 5(d)].

In Fig. 6(a), a CV curve (recorded in the 0.3 V–0.8 V vs Ag potential range) of the $\text{Ni}(\text{OH})_2/\text{NiOOH}$ coated electrode in 0.1M KOH is reported. The CVs collected in this work are comparable to those found in the literature for similar materials.^{35–37,40,41}

The voltammogram in Fig. 6(a) displays two redox peaks centered around 0.45 V (A) and 0.58 V (B) in the cathodic and anodic traces, respectively. The redox waves are likely to be attributed to the following reactions:

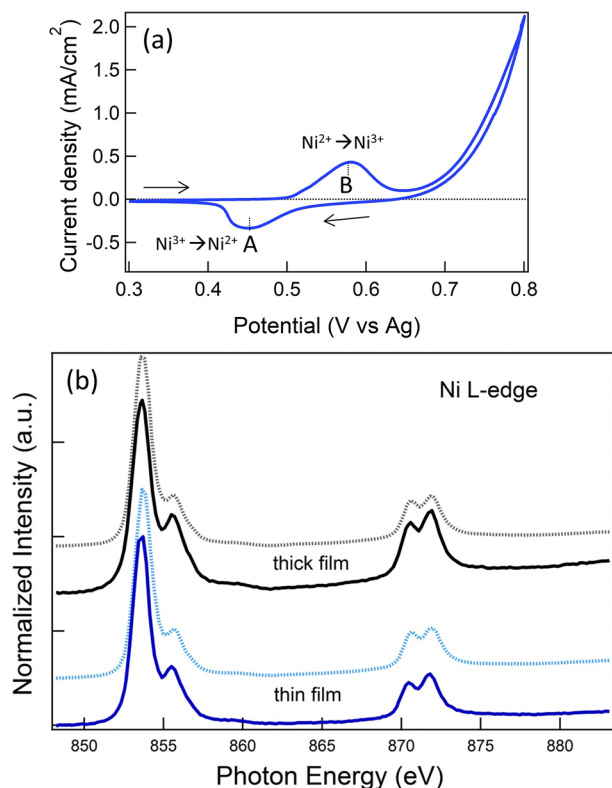
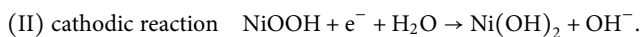
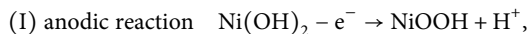


FIG. 6. (a) Example of cyclic voltammetry measured in 0.1M KOH on an electrodeposited $\text{Ni}(\text{OH})_2$ layer (WE) vs an Ag wire pseudo-reference electrode. (b) Ni L-edge XAS measured in total electron yield (dashed lines) and total fluorescence yield (solid lines) on the $\text{Ni}(\text{OH})_2$ thin (bottom curves) and thick layers (top curves).

Thus, the peaks A and B can be attributed to the oxidation of Ni^{2+} to Ni^{3+} in the anodic direction and the corresponding reduction in the cathodic scan.

The $\text{Ni}(\text{OH})_2$ catalyst was characterized *ex situ* by XAS, measuring the Ni L-edges on a separate UHV end station of the BACH beamline. The spectra [see Fig. 6(b)] were measured in both surface sensitive total electron yield (dashed lines) and more bulk sensitive total fluorescence yield mode (solid lines). The photon energy scale was calibrated measuring Au 4f XPS spectra of the Au foil with photon excitation in the first and second order of diffraction. The Ni L-line shape results from the $2p \rightarrow 3d$ dipole transitions split into two regions for the core-hole spin-orbital interaction, the L_3 around 853 eV ($2p_{3/2} \rightarrow 3d$) and the L_2 ($2p_{1/2} \rightarrow 3d$) around 870 eV. The features in both L_3 and L_2 edges originate from atomic multiplet effects and are sensitive both to the electronic and oxidation states of the metal and to the local geometry of Ni atoms. In this case, the Ni L-edge shows the typical features of a 2+ oxidation state.⁴²

B. Operando XAS measurements on Fe-Ni catalyst

Figure 7(a) shows the setup for *operando* experiments. The microfluidic cell has been designed to fit the end station of the central branch line of the BACH beamline. The cell tube is mounted horizontally (parallel to the ground plane) in the experimental chamber on a port-aligner, which allows the optimization of the position of the cell horizontally and vertically [perpendicular to the ground plane; see Fig. 7(b)]. The x-ray beam is focused on the cell by a toroidal mirror (TM). The TM is mounted tilted by 2.5° , with respect to the incoming beam facing down, with a deflecting angle of 5° . After the TM, the light is tilted by 3° with respect to the horizontal plane pointing downward. The use of only one reflecting element limits the loss of flux caused by the reduced reflectivity of the optical elements. Two detectors were used for the XAS measurements in total fluorescence yield: (1) an Hamamatsu MCP, with a background signal of a few counts/s, working at -1600 V supply voltage and 10^6 gain and (2) an AXUV 100 IRC Photodiode. The two detectors are placed symmetrically in front of the cell at an angle of around 20° with respect to the incident direction of the x-ray beam. The incoming flux was monitored by measuring the photocurrent from an Au grid mounted at the beginning of the beamline end station.

As an example of *operando* experiments, we followed, by XAS measurements on the Ni L-edge, the redox processes of a Fe-Ni catalyst previously deposited on the $\text{Si}_3\text{N}_4/\text{Ti}/\text{Au}$ membrane. The sample was cathodically electrodeposited as $\text{Fe}_x\text{Ni}(\text{OH})_2$ following a similar procedure to the one described in the previous paragraph using the same solution with the addition of FeSO_4 to get the desired percentage of Fe (10 mol. %). To define the area of deposition and increase the thickness homogeneity throughout the sample, the $\text{Si}_3\text{N}_4/\text{Ti}/\text{Au}$ membrane was masked by an inert plastic mask (see Fig. S4) while immersed in the electrolyte deposition solution. A fixed cathodic current of 20 mA/cm^2 was applied for 5 s using a Biologic SP-240 potentiostat/galvanostat. The deposited layer thickness was estimated to be 400 nm.

Fe_xNiOOH , formed during the first CV cycle, is known to show a good volume activity, which is the property attributed to solid state catalysts that are able to perform catalytic reactions

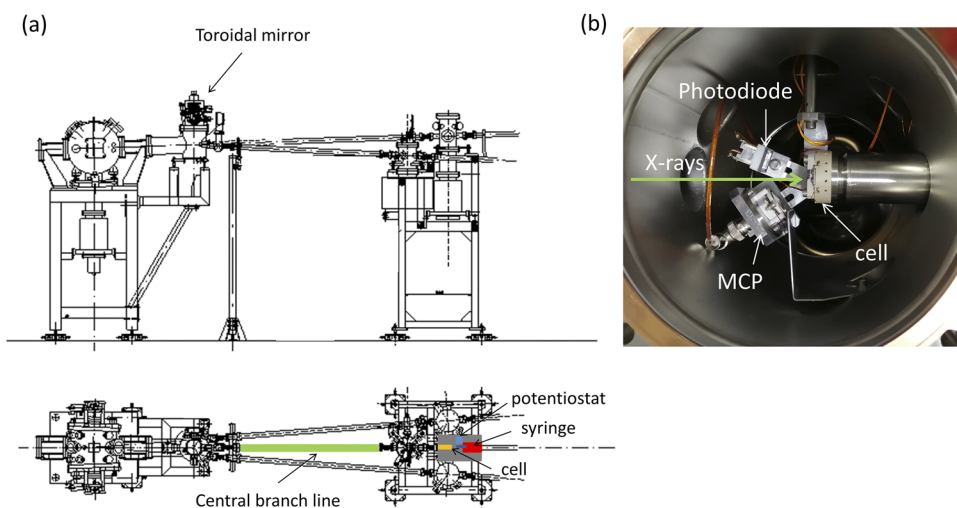


FIG. 7. Setup for *in operando* experiments: (a) side and top schematic view of the toroidal mirror chamber and the beamline end station and (b) picture of the experimental setup where the photodiode and MCP detectors are mounted at around 20° from the incident beam direction at around 4 cm from the cell.

throughout their entire solid volume.^{43–45} The volume activity of the catalyst is very important for *in situ* soft x-ray XAS measurements because of the limited probing depth at this energy range. In fact, the active catalyst surface must be reached by the x rays through the window thickness and the film layer, and then, the emitted photons must be transmitted back to the detector.

Ni L-edge XAS spectra were measured at the open circuit potential in total fluorescence yield using the two detectors (MCP and photodiode; see Fig. S5). They reveal a typical shape of a mostly Ni^{2+} oxidation state,⁴² as confirmed by Ligand Field Multiplet simulations carried out by using the CTM4XAS software developed by Stavitski and de Groot⁴⁶ (Fig. S6).

The CV of the sample measured at RT, in 1M KOH, at a scanning rate of 0.02 V/s is shown in the inset of Fig. 8. The peak centered around 0.78 V can be assigned to the oxidation from Ni^{2+} to Ni^{3+} ,⁴⁷ and the onset of the oxygen evolution reaction (OER) at potential >0.8 V is also visible.⁴⁸

We avoided to increase the potential to values higher than 0.9 V because the generation of oxygen bubbles at the surface of the catalyst may cause the rupture of the Si_3N_4 membrane.

The CVs of Ni and Fe–Ni catalysts are comparable to those reported in the literature.^{35–37,40,41}

Decreasing the potential, the peak at around 0.35 V is assigned to the reduction of Ni^{3+} to Ni^{2+} . Comparing the CVs of Ni (Fig. 6) and Fe–Ni catalysts (Fig. 8), it can be noticed that the potential difference between cathodic and anodic waves in the Fe–Ni catalyst CV is larger than the one in Ni catalyst CV. This behavior can be attributed to a larger cell resistance in the Fe–Ni sample (the used potentiostat was not equipped with correction for uncompensated resistance). The addition of Fe to Ni catalyst is known to decrease the water oxidation overpotential and to shift the $\text{Ni}^{2+/3+}$ redox waves to a higher anodic potential.

The potential was increased above the oxidation potential from 0 V to 0.8 V at a scanning rate of 0.02 V/s and then kept constant during the XAS measurement (red solid line) of the Ni L₃-edge. After that, in the same way, the potential was decreased from 0.8 V

to 0 V and then kept at this last potential during the acquisition of the spectrum (blue solid line). The line shape of the two spectra is characterized by two peaks centered at 853.6 eV and 855.5 eV with different intensity ratios, reflecting the change in the Ni oxidation state.

In agreement with previous reported results^{37,47} on a similar catalyst, at a potential higher than 0.7 V, the increase of the peak at 855.5 eV is mostly related to the formation of Ni^{3+} (see also simulated XAS spectra in Fig. S6).

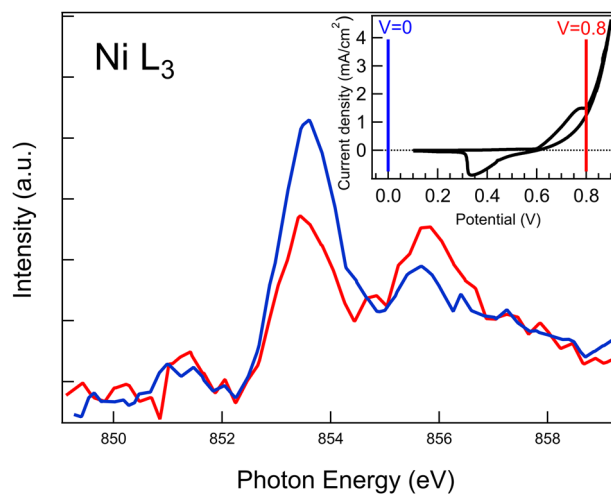


FIG. 8. *In operando* Ni L₃-edge XAS spectra measured in the total fluorescence yield. The blue spectrum is recorded at an applied potential below the reduction potential ($V = 0$), while the red curve is measured at an applied potential above the oxidation potential ($V = 0.8$ V). The inset reports the CV curve of the $\text{Fe}_x\text{Ni}(\text{OH})_2/\text{Fe}_x\text{NiOOH}$.

IV. CONCLUSIONS

We presented static and microfluidic cells for soft x-ray spectroscopy in the presence of fluids, designed and fabricated for the CNR-IOM BACH beamline at the Elettra synchrotron radiation facility in Italy.

Examples of XAS measurements performed using the fluorescence yield on the O K-edge of different samples in aqueous solution and air were performed in the static cell. The design of the microfluidic cell equipped with three electrodes allows us to perform cyclic voltammetry, electrodeposition, and electrochemical reactions under *operando* conditions. As a demonstration of its possibilities, we reported the cathodic electrodeposition of Ni(OH)₂ layers with variable thickness. The morphology of the deposited films was characterized by SEM evidencing the typical porous structure of the material. Ni L-edge XAS measurements revealed the 2+ oxidation state in the electronic structure of Ni(OH)₂. A similar material with higher electrocatalytic performances due the presence of Fe (Fe_xNiOOH) was used to test the cell for XAS measurements performed under *operando* conditions. The XAS spectra recorded on the Ni L-edge at applied potentials above the oxidation and below the reduction potentials show the expected change in the Ni oxidation state.

The presented cells were designed on the basis of the already existing cells and revealed good reliability and versatility. We expect that the availability of these cells at BACH beamline will raise a large interest in the user community for *in situ/operando* experiments on a variety of (electro)catalysts for different applications.

SUPPLEMENTARY MATERIAL

See the [supplementary material](#) for the full description of the cells.

DEDICATION

This work is dedicated to Sandi (Aleksander De Luisa, 1963–2019).

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DATA AVAILABILITY

The data that support the findings of this study are available from the corresponding author upon reasonable request.

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